

TMPIM 50 A CIB/CI Module

NXH50C120L2C2ESG, NXH50C120L2C2ES1G

The NXH50C120L2C2ESG is a transfer-molded power module with low thermal resistance substrate containing a converter-inverter-brake circuit consisting of six 50 A, 1600 V rectifiers, six 50 A, 1200 V IGBTs with inverse diodes, one 35 A, 1200 V brake IGBT with brake diode and an NTC thermistor.

The NXH50C120L2C2ES1G is a transfer-molded power module with low thermal resistance substrate containing a converter-inverter circuit consisting of six 50 A, 1600 V rectifiers, six 50 A, 1200 V IGBTs with inverse diodes, and an NTC thermistor.

Features

- Low Thermal Resistance Substrate for Low Thermal Resistance
- Lower Package Height than Standard Case Modules
- 6 mm Clearance distance between pin to heatsink
- Compact 73 mm × 40 mm × 8 mm Package
- Solderable Pins
- Thermistor
- These Devices are Pb-Free, Halogen Free/BFR Free and are RoHS Compliant

Typical Applications

- Industrial Motor Drives
- Servo Drives

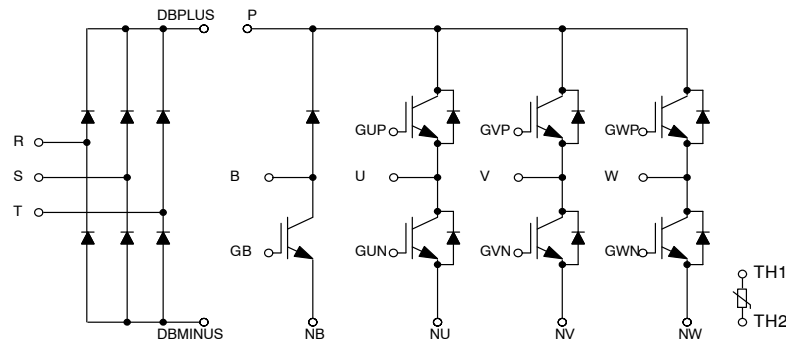


Figure 1. NXH50C120L2C2ESG Schematic Diagram

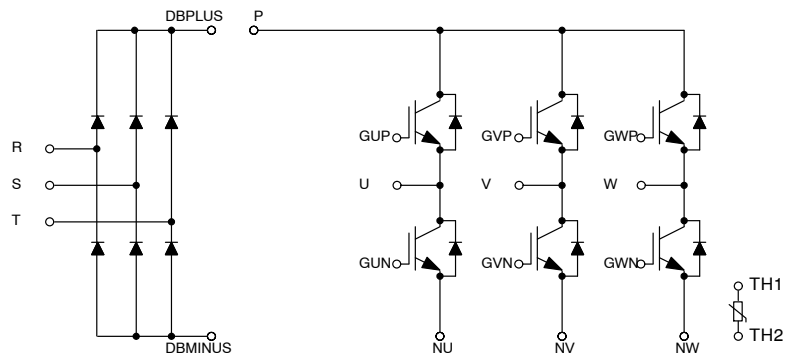
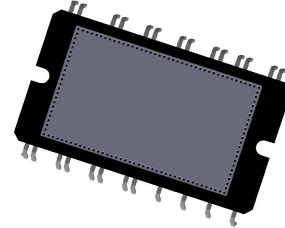


Figure 2. NXH50C120L2C2ES1G Schematic Diagram



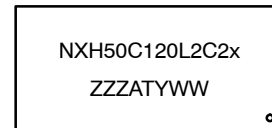
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DIP26 67.8x40
CASE 181AD

MARKING DIAGRAM



NXH50C120L2C2 = Specific Device Code
x = ESG / ES1G
ZZZ = Assembly Lot Code
AT = Assembly & Test Location
Y = Year
WW = Work Week

ORDERING INFORMATION

Device	Package	Shipping†
NXH50C120L2C2ESG	DIP26 (Pb-Free)	6 Units / Tube
NXH50C120L2C2ES1G		

NXH50C120L2C2ESG, NXH50C120L2C2ES1G

MAXIMUM RATINGS (Note 1)

Rating	Symbol	Value	Unit
IGBT (INVERTER, BRAKE)			
Collector-emitter Voltage	V_{CES}	1200	V
Gate-emitter Voltage	V_{GE}	± 20	V
Inverter IGBT Continuous Collector Current @ $T_C = 100^\circ\text{C}$ ($T_{VJmax} = 175^\circ\text{C}$)	I_C	50	A
Inverter IGBT Pulsed Collector Current ($T_{VJmax} = 175^\circ\text{C}$)	I_{Cpulse}	150	A
Brake IGBT Continuous Collector Current @ $T_C = 100^\circ\text{C}$ ($T_{VJmax} = 175^\circ\text{C}$)	I_C	35	A
Brake IGBT Pulsed Collector Current ($T_{VJmax} = 175^\circ\text{C}$)	I_{Cpulse}	105	A

DIODE (INVERTER, BRAKE)

Peak Repetitive Reverse Voltage	V_{RRM}	1200	V
Inverter Diode Continuous Forward Current @ $T_C = 80^\circ\text{C}$ ($T_{VJmax} = 17^\circ\text{C}$)	I_F	50	A
Inverter Diode Repetitive Peak Forward Current ($T_{VJmax} = 175^\circ\text{C}$)	I_{FRM}	150	A
Inverter Diode I^2t value (60 Hz single half-sine wave)	I^2t	94	A^2t
Brake Diode Continuous Forward Current @ $T_C = 80^\circ\text{C}$ ($T_{VJmax} = 175^\circ\text{C}$)	I_F	35	A
Brake Diode Repetitive Peak Forward Current ($T_{VJmax} = 175^\circ\text{C}$)	I_{FRM}	105	A
Brake Diode I^2t value (60 Hz single half-sine wave)	I^2t	46	A^2t

RECTIFIER DIODE

Peak Repetitive Reverse Voltage	V_{RRM}	1600	V
Continuous Forward Current @ $T_C = 80^\circ\text{C}$ ($T_{VJmax} = 150^\circ\text{C}$)	I_F	50	A
Repetitive Peak Forward Current ($T_{VJmax} = 150^\circ\text{C}$)	I_{FRM}	150	A
I^2t value (60 Hz single half-sine wave) @ 25°C (60 Hz single half-sine wave) @ 150°C	I^2t	1126 510	A^2t
Surge current (10ms sin180°) @ 25°C	I_{FSM}	520	A

MODULE THERMAL PROPERTIES

Storage Temperature Range	T_{stg}	-40 to 125	$^\circ\text{C}$
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INSULATION PROPERTIES

Isolation Test Voltage, $t = 1$ s, 50 Hz	V_{is}	3000	V_{RMS}
Internal Isolation		HPS	
Creepage Distance		6.0	mm
Clearance Distance		6.0	mm
Comperative Tracking Index	CTI	>400	

Stresses exceeding those listed in the Maximum Ratings table may damage the device. If any of these limits are exceeded, device functionality should not be assumed, damage may occur and reliability may be affected.

1. Refer to ELECTRICAL CHARACTERISTICS, RECOMMENDED OPERATING RANGES and/or APPLICATION INFORMATION for Safe Operating parameters.

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ELECTRICAL CHARACTERISTICS (T_J = 25°C unless otherwise specified)

Parameter	Test Conditions	Symbol	Min	Typ	Max	Unit	
INVERTER IGBT CHARACTERISTICS							
Collector-emitter Cutoff Current	V _{GE} = 0 V, V _{CE} = 1200 V	I _{CES}	–	–	250	μA	
Collector-emitter Saturation Voltage	V _{GE} = 15 V, I _C = 50 A, T _J = 25°C	V _{CE(sat)}	–	1.8	2.4	V	
	V _{GE} = 15 V, I _C = 50 A, T _J = 150°C		–	2	–		
Gate-emitter Threshold Voltage	V _{GE} = V _{CE} , I _C = 6 mA	V _{GE(TH)}	4.8	6	6.8	V	
Gate Leakage Current	V _{GE} = 20 V, V _{CE} = 0 V	I _{GES}	–	–	400	nA	
Turn-on Delay Time	T _J = 25°C V _{CE} = 600 V, I _C = 50 A V _{GE} = ±15 V, R _G = 15 Ω	t _{d(on)}	–	144	–	ns	
Rise Time		t _r	–	104	–		
Turn-off Delay Time		t _{d(off)}	–	380	–		
Fall Time		t _f	–	52	–		
Turn-on Switching Loss per Pulse		E _{on}	–	5870	–		μJ
Turn-off Switching Loss per Pulse		E _{off}	–	1700	–		
Turn-on Delay Time		T _J = 150°C V _{CE} = 600 V, I _C = 50 A V _{GE} = ±15 V, R _G = 15 Ω	t _{d(on)}	–	136		–
Rise Time	t _r		–	112	–		
Turn-off Delay Time	t _{d(off)}		–	432	–		
Fall Time	t _f		–	184	–		
Turn-on Switching Loss per Pulse	E _{on}		–	9530	–	μJ	
Turn-off Switching Loss per Pulse	E _{off}		–	3800	–		
Input Capacitance	V _{CE} = 20 V, V _{GE} = 0 V, f = 100 kHz		C _{ies}	–	11897	–	pF
Output Capacitance		C _{oes}	–	416	–		
Reverse Transfer Capacitance		C _{res}	–	240	–		
Total Gate Charge	V _{CE} = 600 V, I _C = 50 A, V _{GE} = 0 V ~ ±15 V	Q _g	–	558	–	nC	
Temperature under switching conditions		T _{vj op}	–40		150	°C	
Thermal Resistance – Chip-to-Case		R _{thJC}	–	0.26	–	°C/W	

INVERSE DIODE CHARACTERISTICS

Diode Forward Voltage	I _F = 50 A, T _J = 25°C	V _F	–	1.9	2.7	V
	I _F = 50 A, T _J = 150°C		–	1.7	–	
Reverse Recovery Charge	T _J = 25°C V _{CE} = 600 V, I _C = 50 A V _{GE} = ±15 V, R _G = 15 Ω	Q _{rr}	–	2.58	–	μC
Peak Reverse Recovery Current		I _{RRM}	–	20	–	A
Reverse Recovery Energy		E _{rr}	–	640	–	μJ
Reverse Recovery Charge	T _J = 150°C V _{CE} = 600 V, I _C = 50 A V _{GE} = ±15 V, R _G = 15 Ω	Q _{rr}	–	8.0	–	μC
Peak Reverse Recovery Current		I _{RRM}	–	32.5	–	A
Reverse Recovery Energy		E _{rr}	–	2300	–	μJ
Temperature under switching conditions		T _{vj op}	–40		150	°C
Thermal Resistance – Chip-to-Case		R _{thJC}	–	0.42	–	°C/W

NXH50C120L2C2ESG, NXH50C120L2C2ES1G

ELECTRICAL CHARACTERISTICS ($T_J = 25^\circ\text{C}$ unless otherwise specified) (continued)

Parameter	Test Conditions	Symbol	Min	Typ	Max	Unit
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RECTIFIER DIODE CHARACTERISTICS

Diode Forward Voltage	$I_F = 50\text{ A}, T_J = 25^\circ\text{C}$	V_F	–	1.2	1.6	V
	$I_F = 50\text{ A}, T_J = 150^\circ\text{C}$		–	1.1	–	
Temperature under switching conditions		$T_{vj\ op}$	–40		150	$^\circ\text{C}$
Thermal Resistance – Chip-to-Case		R_{thJC}	–	0.33	–	$^\circ\text{C/W}$

BRAKE IGBT CHARACTERISTICS

Collector-emitter Cutoff Current	$V_{GE} = 0\text{ V}, V_{CE} = 1200\text{ V}$	I_{CES}	–	–	250	μA
Collector-emitter Saturation Voltage	$V_{GE} = 15\text{ V}, I_C = 35\text{ A}, T_J = 25^\circ\text{C}$	$V_{CE(sat)}$	–	1.8	2.4	V
	$V_{GE} = 15\text{ V}, I_C = 35\text{ A}, T_J = 125^\circ\text{C}$		–	1.9	–	
Gate-emitter Threshold Voltage	$V_{GE} = V_{CE}, I_C = 4.25\text{ mA}$	$V_{GE(TH)}$	4.8	6	6.8	V
Gate Leakage Current	$V_{GE} = 20\text{ V}, V_{CE} = 0\text{ V}$	I_{GES}	–	–	400	nA
Turn-on Delay Time	$T_J = 25^\circ\text{C}$ $V_{CE} = 600\text{ V}, I_C = 35\text{ A}$ $V_{GE} = \pm 15\text{ V}, R_G = 15\ \Omega$	$t_{d(on)}$	–	104	–	ns
Rise Time		t_r	–	64	–	
Turn-off Delay Time		$t_{d(off)}$	–	277	–	
Fall Time		t_f	–	53	–	
Turn-on Switching Loss per Pulse		E_{on}	–	2900	–	μJ
Turn off Switching Loss per Pulse		E_{off}	–	1200	–	
Turn-on Delay Time		$T_J = 150^\circ\text{C}$ $V_{CE} = 600\text{ V}, I_C = 35\text{ A}$ $V_{GE} = \pm 15\text{ V}, R_G = 15\ \Omega$	$t_{d(on)}$	–	168	–
Rise Time	t_r		–	72	–	
Turn-off Delay Time	$t_{d(off)}$		–	320	–	
Fall Time	t_f		–	165	–	
Turn-on Switching Loss per Pulse	E_{on}		–	4030	–	μJ
Turn off Switching Loss per Pulse	E_{off}		–	2200	–	
Input Capacitance	$V_{CE} = 20\text{ V}, V_{GE} = 0\text{ V},$ $f = 100\text{ kHz}$		C_{ies}	–	8333	–
Output Capacitance		C_{oes}	–	298	–	
Reverse Transfer Capacitance		C_{res}	–	175	–	
Total Gate Charge	$V_{CE} = 600\text{ V}, I_C = 35\text{ A},$ $V_{GE} = 0\text{ V} \sim +15\text{ V}$	Q_g	–	360	–	nC
Temperature under switching conditions		$T_{vj\ op}$	–40		150	$^\circ\text{C}$
Thermal Resistance – Chip-to-Case		R_{thJC}	–	0.42	–	$^\circ\text{C/W}$

BRAKE DIODE CHARACTERISTICS

Brake Diode Reverse Leakage Current	$V_R = 1200\text{ V}$	I_R	–	–	200	μA	
Diode Forward Voltage	$I_F = 35\text{ A}, T_J = 25^\circ\text{C}$	V_F	–	2.2	2.7	V	
	$I_F = 35\text{ A}, T_J = 150^\circ\text{C}$		–	2	–		
Reverse Recovery Time	$T_J = 25^\circ\text{C}$ $V_{CE} = 600\text{ V}, I_C = 35\text{ A}$ $V_{GE} = \pm 15\text{ V}, R_G = 15\ \Omega$	t_{rr}	–	224	–	ns	
Reverse Recovery Charge		Q_{rr}	–	1.51	–	$^\circ\text{C}$	
Peak Reverse Recovery Current		I_{RRM}	–	18	–	A	
Reverse Recovery Energy		E_{rr}	–	410	–	μJ	
Reverse Recovery Time		$T_J = 150^\circ\text{C}$ $V_{CE} = 600\text{ V}, I_C = 35\text{ A}$ $V_{GE} = \pm 15\text{ V}, R_G = 15\ \Omega$	t_{rr}	–	532	–	ns
Reverse Recovery Charge			Q_{rr}	–	5,36	–	$^\circ\text{C}$
Peak Reverse Recovery Current			I_{RRM}	–	30	–	A
Reverse Recovery Energy	E_{rr}		–	1983	–	μJ	
Temperature under switching conditions		$T_{vj\ op}$	–40		150	$^\circ\text{C}$	
Thermal Resistance – Chip-to-Case		R_{thJC}	–	0.65	–	$^\circ\text{C/W}$	

NXH50C120L2C2ESG, NXH50C120L2C2ES1G

ELECTRICAL CHARACTERISTICS (T_J = 25°C unless otherwise specified) (continued)

Parameter	Test Conditions	Symbol	Min	Typ	Max	Unit
THERMISTOR CHARACTERISTICS						
Nominal Resistance	T = 25°C	R ₂₅	–	5	–	kΩ
Nominal Resistance	T = 100°C	R ₁₀₀	–	493.3	–	Ω
Deviation of R25		ΔR/R	–5	–	5	%
Power Dissipation		P _D	–	20	–	mW
Power Dissipation Constant			–	1.4	–	mW/K
B-value	B(25/50), tolerance ±2%		–	3375	–	K
B-value	B(25/100), tolerance ±2%		–	3433	–	K

Product parametric performance is indicated in the Electrical Characteristics for the listed test conditions, unless otherwise noted. Product performance may not be indicated by the Electrical Characteristics if operated under different conditions.

NXH50C120L2C2ESG, NXH50C120L2C2ES1G

TYPICAL CHARACTERISTICS – INVERTER IGBT & INVERSE DIODE

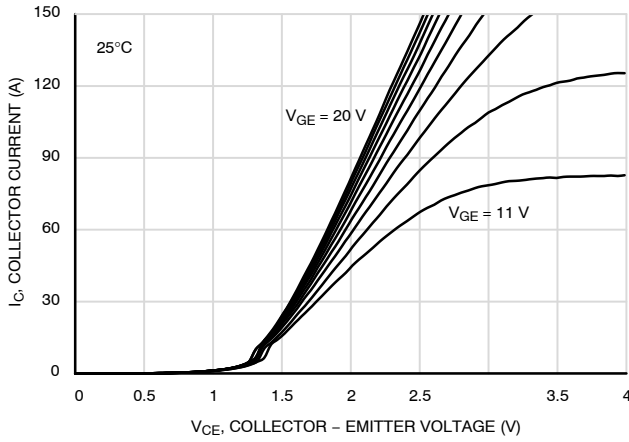


Figure 3. Inverter IGBT Typical Output Characteristic (25°C)

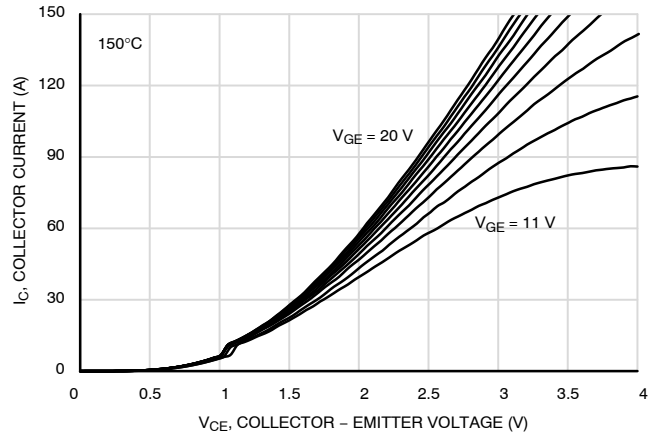


Figure 4. Inverter IGBT Typical Output Characteristic (150°C)

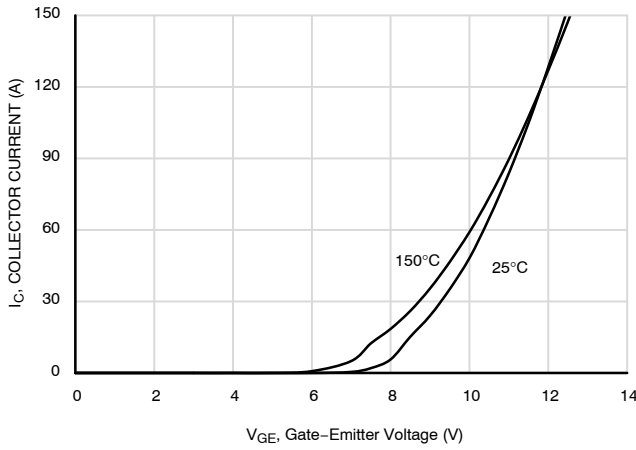


Figure 5. Inverter IGBT Typical Transfer Characteristic

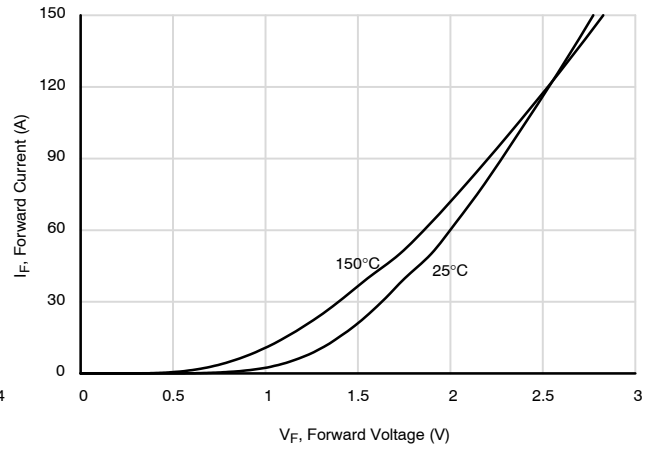


Figure 6. Inverter Diode Typical Forward Characteristic

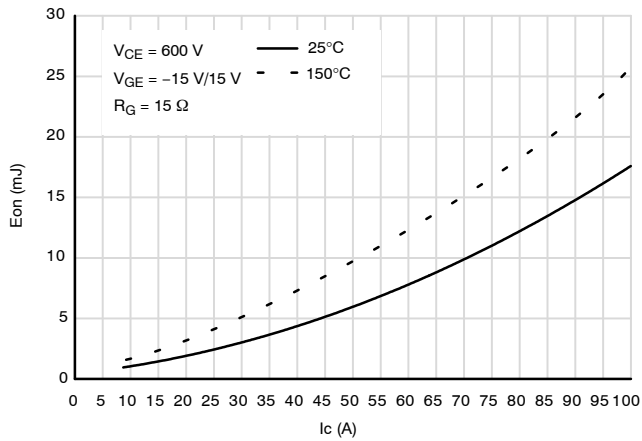


Figure 7. Inverter IGBT Typical Turn On Loss vs IC

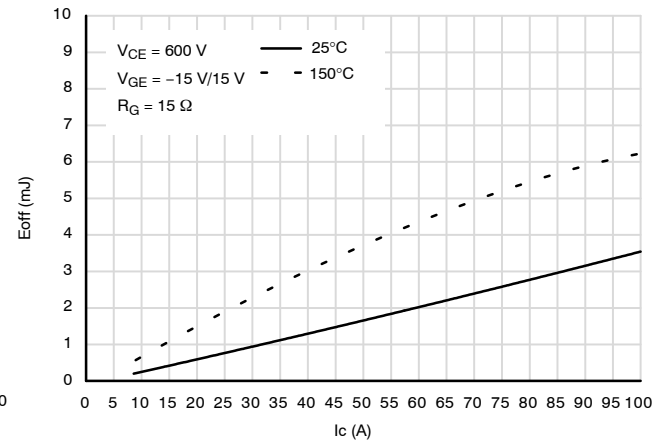


Figure 8. Inverter IGBT Typical Turn Off Loss vs IC

NXH50C120L2C2ESG, NXH50C120L2C2ES1G

TYPICAL CHARACTERISTICS – INVERTER IGBT & INVERSE DIODE

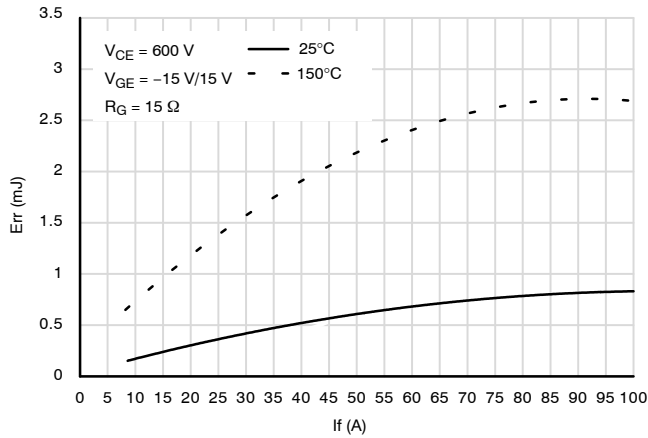


Figure 9. Inverter Diode Typical Reverse Recovery Energy vs IC

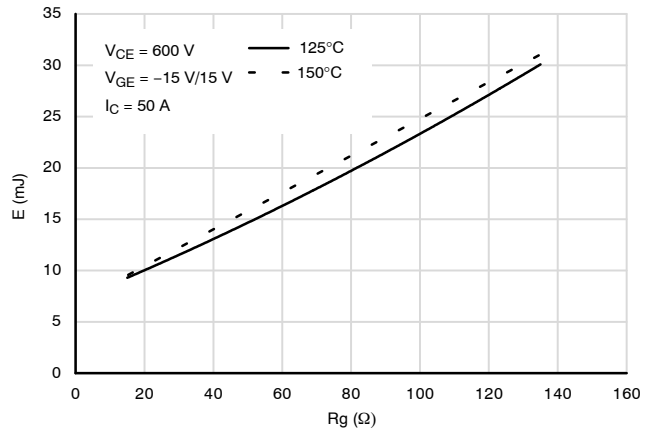


Figure 10. Inverter IGBT Typical Turn On Loss vs RG

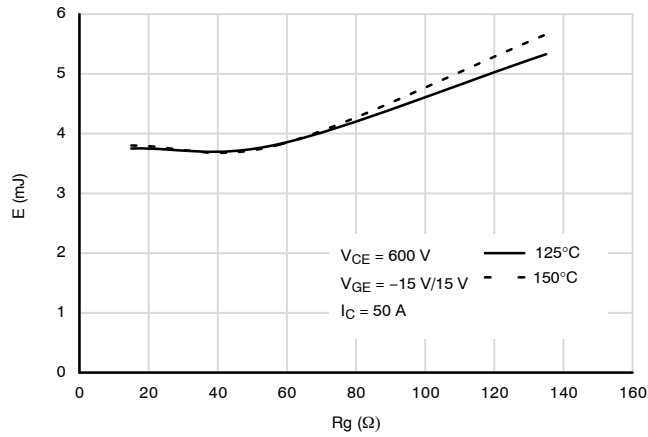


Figure 11. Inverter IGBT Typical Turn Off Loss vs RG

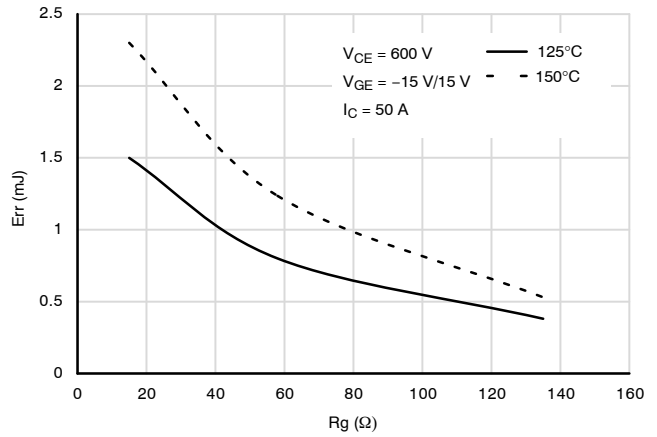


Figure 12. Inverter Diode Typical Reverse Recovery Energy vs RG

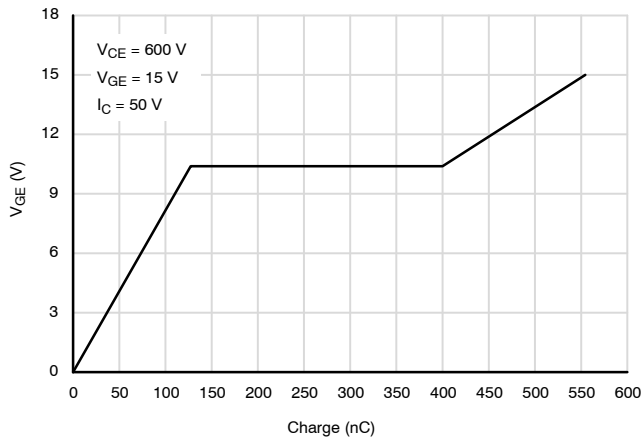


Figure 13. Inverter IGBT Gate Voltage vs Gate Charge

NXH50C120L2C2ESG, NXH50C120L2C2ES1G

TYPICAL CHARACTERISTICS – INVERTER IGBT & INVERSE DIODE

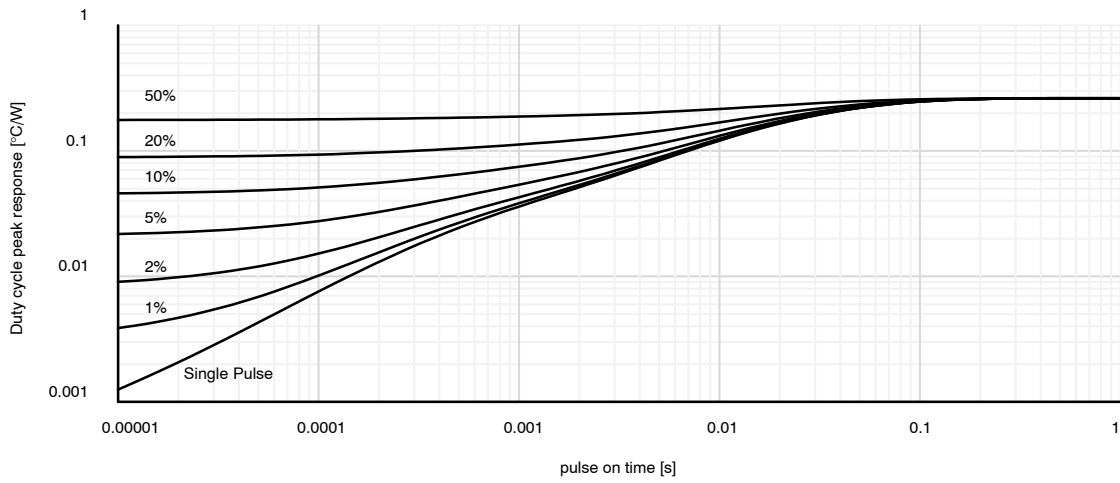


Figure 14. Inverter IGBT Junction-to-case Transient Thermal Impedance

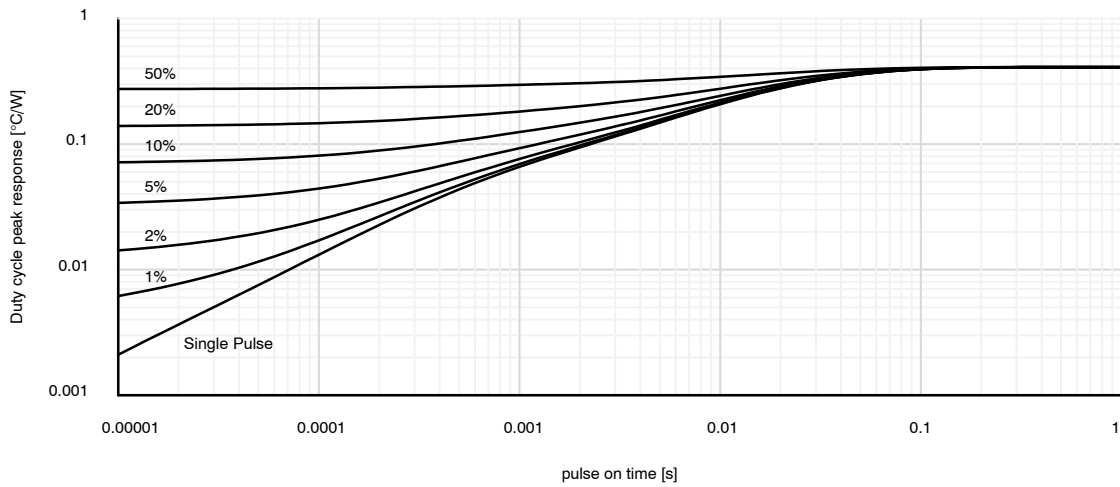


Figure 15. Inverter Diode Junction-to-case Transient Thermal Impedance

NXH50C120L2C2ESG, NXH50C120L2C2ES1G

TYPICAL CHARACTERISTICS – BRAKE IGBT & BRAKE DIODE

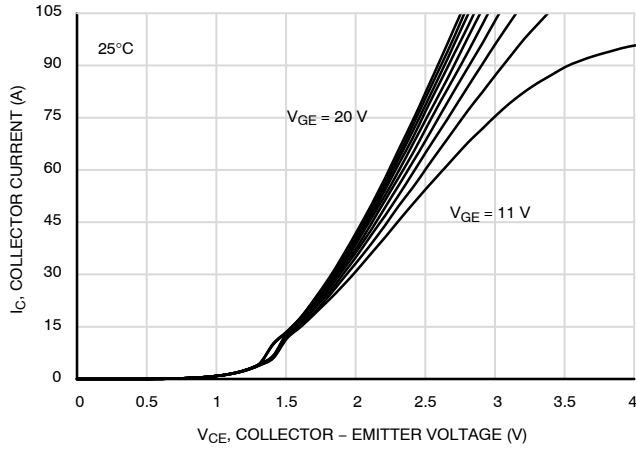


Figure 16. Brake IGBT Typical Output Characteristic (25°C)

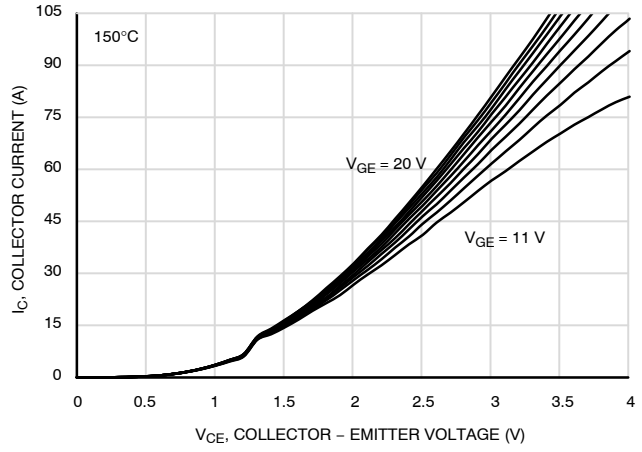


Figure 17. Brake IGBT Typical Output Characteristic (150°C)

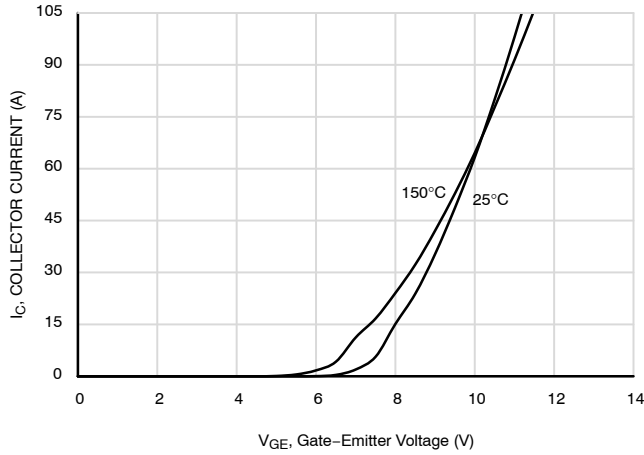


Figure 18. Brake IGBT Typical Transfer Characteristic

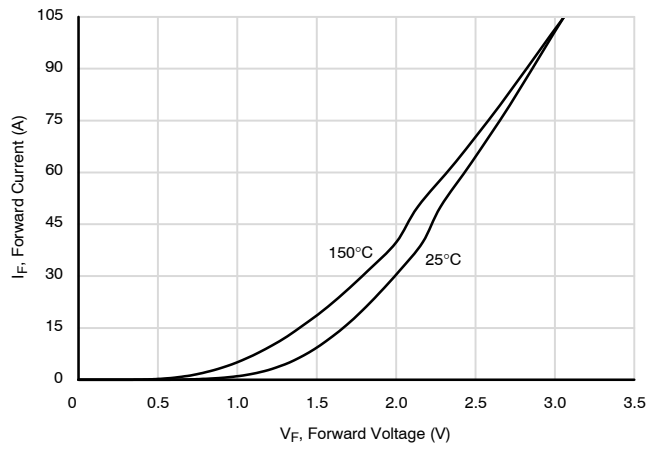


Figure 19. Brake Diode Typical Forward Characteristic

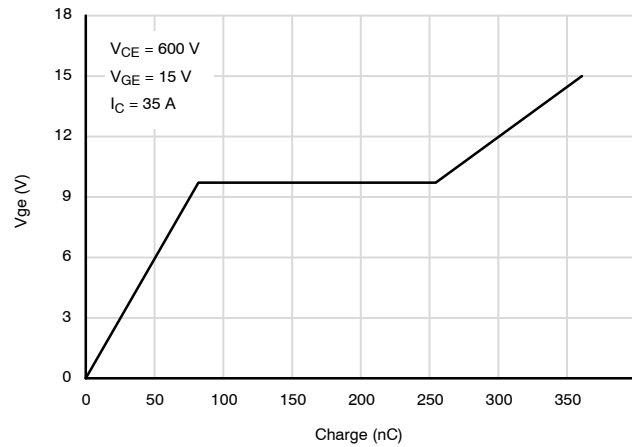


Figure 20. Brake IGBT Gate Voltage vs Gate Charge

NXH50C120L2C2ESG, NXH50C120L2C2ES1G

TYPICAL CHARACTERISTICS – RECTIFIER

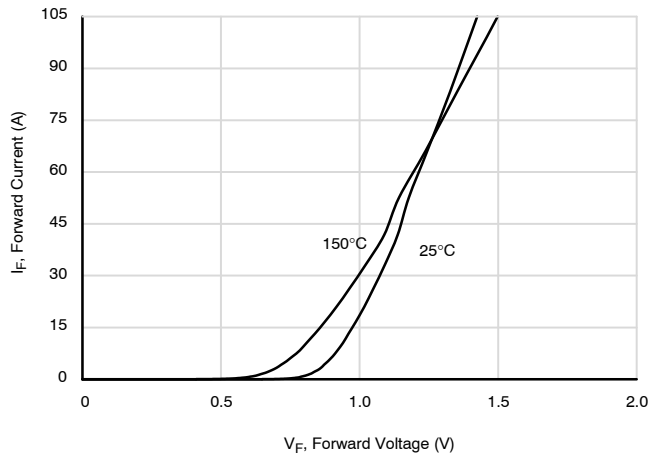


Figure 21. Rectifier Typical Forward Characteristic

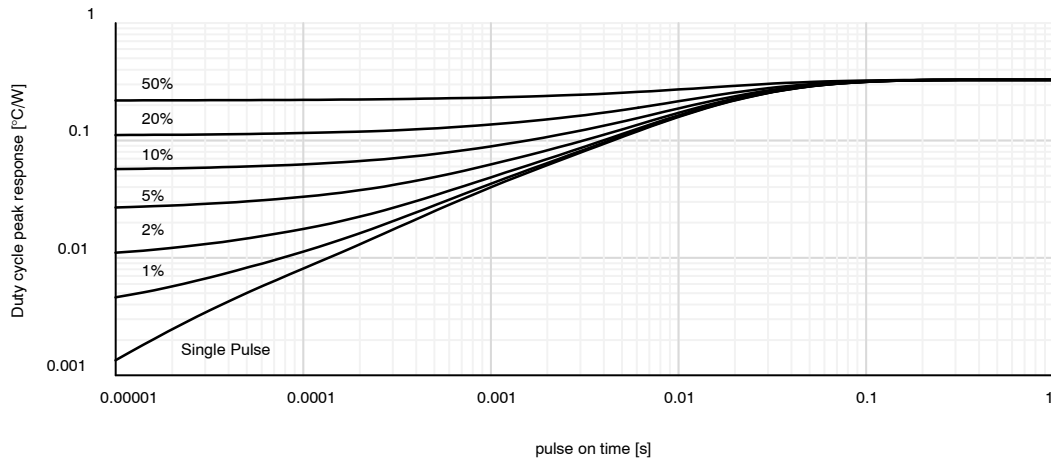


Figure 22. Rectifier Junction-to-Case Transient Thermal Impedance

MECHANICAL CASE OUTLINE

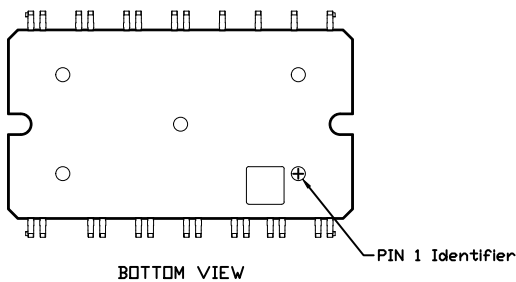
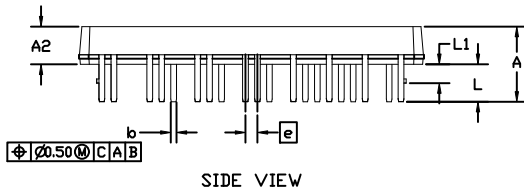
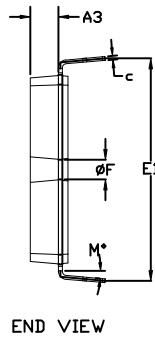
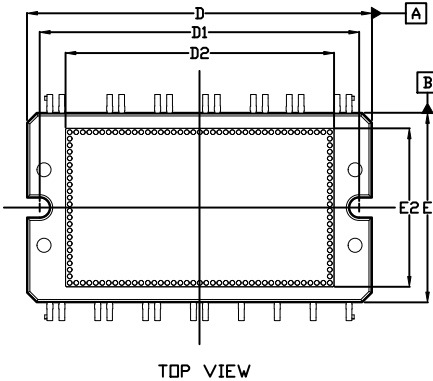
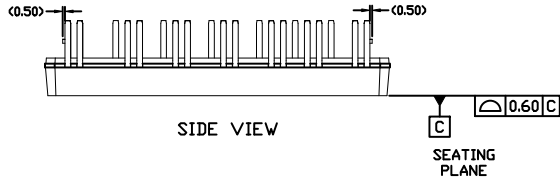
PACKAGE DIMENSIONS

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ISSUE A

DATE 25 FEB 2020

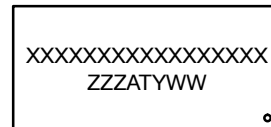


NOTES:

1. DIMENSIONING AND TOLERANCING PER ASME Y14.5M, 2009.
2. CONTROLLING DIMENSION: MILLIMETERS
3. DIMENSIONS ARE EXCLUSIVE OF BURRS, MOLD FLASH, AND TIE BAR EXTRUSIONS.
4. DIMENSIONS b AND c APPLY TO PLATED LEADS
5. POSITION OF THE LEADS IS DETERMINED AT THE ROOT OF THE LEAD WHERE IT EXITS THE PACKAGE BODY
6. MISSING PINS ARE 3,4,7,10,11,14,15,18,19,22,23,24,29, 30,33,34,37,38,41,42,44,45,47,48,50,51

DIM	MILLIMETERS		
	MIN	NOM	MAX
A	15.50	16.00	16.50
A2	7.80	8.00	8.20
A3	6.00 REF		
b	1.10	1.20	1.30
c	0.70	0.80	0.90
D	72.70	73.20	73.70
D1	67.30	67.80	68.30
D2	57.30 REF		
E	39.70	40.20	40.70
E1	46.70	47.20	47.70
E2	33.87 REF		
e	2.54 BSC		
F	4.00	4.20	4.40
L	8.00 REF		
L1	3.50	4.00	4.50
M	4°	5°	6°

GENERIC MARKING DIAGRAM*



XXX = Specific Device Code
 ZZZ = Assembly Lot Code
 AT = Assembly & Test Location
 Y = Year
 WW = Work Week

*This information is generic. Please refer to device data sheet for actual part marking. Pb-Free indicator, "G" or microdot "μ", may or may not be present. Some products may not follow the Generic Marking.

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